

## P-Channel 20-V (D-S) MOSFET

#### Description

The MS23P01 is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the small power switching and load switch applications.

The device meets the RoHS and Green Product requirement with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

#### **Typical Applications**

- Notebook
- Load Switch
- Hand-held Instrument

Package type: SOT-23

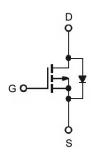
#### **Packing & Order Information**

3,000/Reel

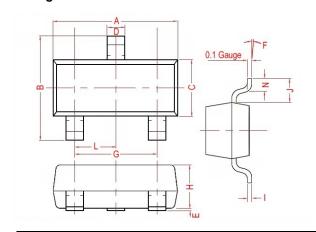


RoHS Compliant

#### **Graphic Symbol**

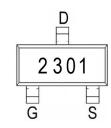


#### **Package Dimension**



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	NEF.	Min.	Max.	
Α	2.70	3.10	G	1.90 Ref.		
В	2.30	3.00	Н	0.90	1.30	
С	1.20	1.75	- 1	0.05	0.21	
D	0.30	0.50	J	0.58 Ref.		
E	0.01	0.15	L	0.95 Typ.		
F	0°	10°	Ν	0.20 Min.		

#### Marking





## P-Channel 20-V (D-S) MOSFET

#### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (unless otherwise specified)					
Symbol	Parameter	Value	Units		
$V_{\text{DS}}$	Drain-Source Voltage	-20	V		
V <sub>G</sub> s	Gate-Source Voltage	±12	V		
I-	Continuous Drain Current¹ (T <sub>A</sub> =25°C)	-3.3	Α		
ID	Continuous Drain Current <sup>1</sup> (T <sub>A</sub> =70°C)	-2.6	Α		
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup> (T <sub>A</sub> =25°C)	-13	Α		
P <sub>D</sub>	Power Dissipation <sup>3</sup> (T <sub>A</sub> =25°C)	1.4	W		
TJ/T <sub>STG</sub>	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
R <sub>0JA</sub>	Maximum Junction-to-Ambient <sup>3</sup>	125	°C/W		

Electrical Characteristics(T」=25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$V_{GS(th)}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	-0.45	-0.6	-1.0	V
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	-20	-	-	V
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-3A	-	12.2	-	S
Igss	Gate-Source Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V	-	-	±100	nA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =16V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-		-1	μΑ
		V <sub>DS</sub> =16V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C		-	-5	
	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.0A	-	76	100	mΩ
R <sub>DS (on)</sub>		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-2.0A		110	135	
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-0.9A		160	240	
$V_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	Is =-1.0A, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-	-	-1	V
Is	Continuous Source Current <sup>1,4</sup> ( <b>Diode</b> )	V -V -OV Force Comment	_	-	-3	_
Ism	Pulsed Source Current <sup>2,4</sup> (Diode)	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	-	-	-12	Α

#### **Notes**

- 1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
- 4. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



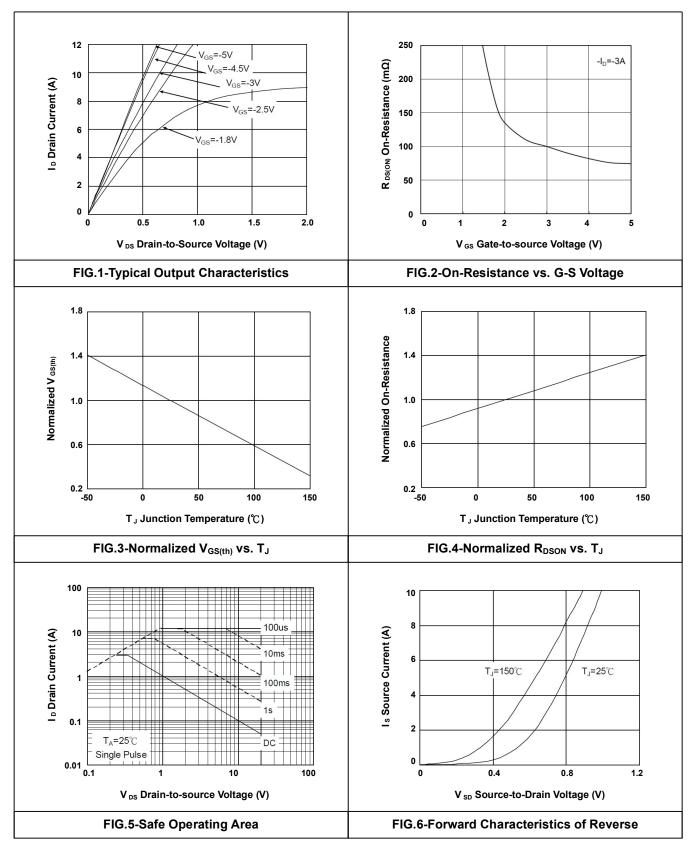
# P-Channel 20-V (D-S) MOSFET

Dynamic and switching Characteristics						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge <sup>2</sup>	V <sub>DS</sub> =-15V		10.1		
Qgs	Gate-Source Charge	I <sub>D</sub> =-3A		1.21		nC
Qgd	Gate-Drain Charge	V <sub>GS</sub> =-4.5V		2.46		
t <sub>d(on)</sub>	Turn-On Delay Time <sup>2</sup>	V <sub>DS</sub> =-10V		5.6		
tr	Rise Time	I <sub>D</sub> =-3A		32.2		
td(off)	Turn-Off Delay Time	V <sub>GS</sub> =-4.5V		45.6		ns
tf	Fall Time	R <sub>G</sub> =3.3Ω		29.2		
C <sub>ISS</sub>	Input Capacitance	V <sub>DS</sub> =-15V		677		
Coss	Output Capacitance	V <sub>GS</sub> =0V		82		pF
Crss	Reverse Transfer Capacitance	f =1.0MHz		73		



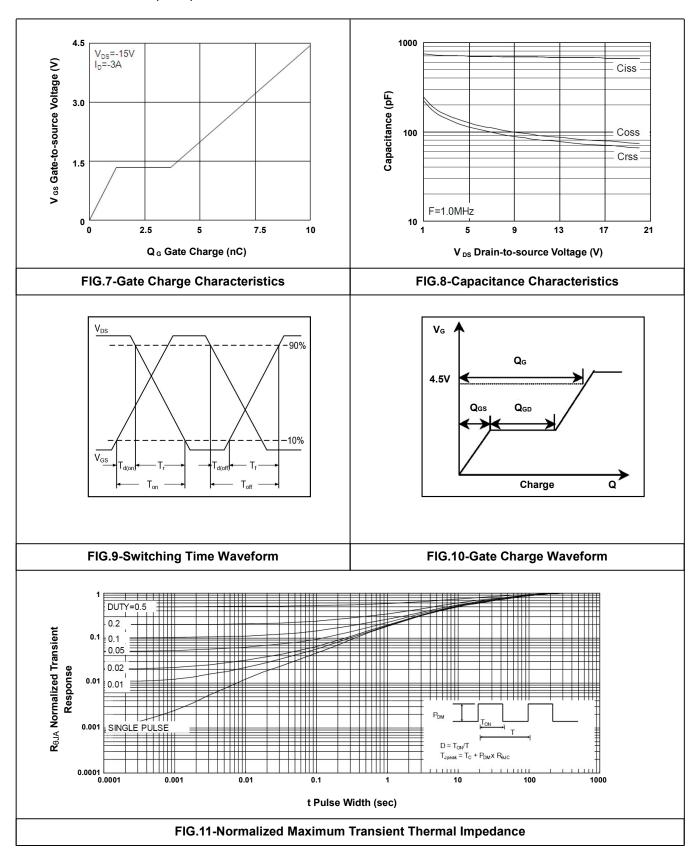
## P-Channel 20-V (D-S) MOSFET

#### • Typical Electrical Characteristics





## P-Channel 20-V (D-S) MOSFET





P-Channel 20-V (D-S) MOSFET

#### **Disclaimer**

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE. Bruckewell Technology Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Bruckewell"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product. Bruckewell makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Bruckewell disclaims

- (i) Any and all liability arising out of the application or use of any product.
- (ii) Any and all liability, including without limitation special, consequential or incidental damages.
- (iii) Any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Bruckewell's knowledge of typical requirements that are often placed on Bruckewell products in generic applications.

Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and/or specifications may vary in different applications and performance may vary over time.

Product specifications do not expand or otherwise modify Bruckewell's terms and conditions of purchase, including but not limited to the warranty expressed therein.